

Notice of References Cited <i>SUPPLEMENTAL NON-FINAL</i> <i>PD# 09/25/07</i>	Application/Control No. 10/672,095	Applicant(s)/Patent Under Reexamination CHOI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0037747 A1	03-2002	Ueno, Fumihiko	455/557
*	B	US-7,106,375 B2	09-2006	Venturino et al.	348/333.02
*	C	US-2002/0137544 A1	09-2002	Myojo, Toshihiko	455/557
*	D	US-2003/0027603 A1	02-2003	Takasaki, Atsushi	455/566
*	E	US-7,117,519 B1	10-2006	Anderson et al.	725/105
*	F	US-6,771,896 B2	08-2004	Tamura et al.	396/57
*	G	US-6,792,293 B1	09-2004	Awan et al.	455/566
*	H	US-7,158,266 B2	01-2007	Kameyama, Takaki	358/403
*	I	US-6,957,045 B2	10-2005	Haller et al.	455/41.1
*	J	US-6,927,770 B2	08-2005	Ording, Bas	345/440
*	K	US-2002/0155478 A1	10-2002	Nelson et al.	435/6
*	L	US-7,092,671 B2	08-2006	Lunsford et al.	455/41.2
*	M	US-7,184,797 B2	02-2007	Burnhouse et al.	455/566

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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